

Sheet 1 of 2							
FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: January 22, 2004	<table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 30%; padding: 2px;">ATTY DOCKET NO. 2004-0092</td> <td style="width: 70%; padding: 2px;">SERIAL NO. NEW 10/761,412</td> </tr> <tr> <td colspan="2" style="padding: 2px;">APPLICANT Makoto IMANISHI et al.</td> </tr> <tr> <td style="width: 60%; padding: 2px;">FILING DATE January 22, 2004</td> <td style="width: 40%; padding: 2px;">GROUP 1725</td> </tr> </table>	ATTY DOCKET NO. 2004-0092	SERIAL NO. NEW 10/761,412	APPLICANT Makoto IMANISHI et al.		FILING DATE January 22, 2004	GROUP 1725
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APPLICANT Makoto IMANISHI et al.							
FILING DATE January 22, 2004	GROUP 1725						
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AM	AA	4,024,560	05/1977	Miller et al.			
	AB	4,518,848	05/1985	Weber			
	AC	6,544,377	04/2003	Minamitani et al.			
	AD	6,439,447	08/2002	Minamitani et al.			
	AE	6,329,640	12/2001	Narita et al.			
	AF	6,302,317	10/2001	Narita et al.			
	AG	6,506,222	01/2003	Minamitani et al.			
	AH	6,053,398	04/2000	Iizuka et al.			
AM	AI	4,846,623	07/1989	Otani et al.			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
AM	AJ	8-78418	03/1996	JP			Abstract
	AK	7-153763	06/1995	JP			Abstract
	AL	96/41109	12/1996	WO			
AM	AM	09-289241	04/1997	JP			Abstract
	AN						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AO	Patent Abstracts of Japan, vol. 1996, no. 07, July 31, 1996 (7/31/96) & JP 08 078418 A (Toshiba Corp.), March 22, 1996 (3/22/96) - English Abstract					
	AP	N. Miyazaki et al., "Thermal shock cracking of lithium niobate single crystal", Journal of Materials Science, Materials in Electronics, Chapman & Hall, Vol. 8, No. 3, pgs 133-138 (1997).					
	AQ						
EXAMINER				DATE CONSIDERED 10/30/2006			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 2 of 2 FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: January 22, 2004				ATTY DOCKET NO. 2004-0092		SERIAL NO. NEW 10/761,412	
APPLICANT Makoto IMANISHI et al.				FILING DATE January 22, 2004		GROUP 1725	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
AM	AA	5,430,271	07/1995	Orgami et al.			
	AB	5,489,192	02/1996	Taniguchi			
	AG	5,664,254	09/1997	Ohkura et al.			
	AD	5,817,178	10/1998	Mita et al.			
AM	AE	5,848,868	12/1998	Suzuki et al.			
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	AJ	09-050957	02/1997	JP			X
	AK						
	AL						
	AM						
	AN						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
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	AP						
	AQ						
EXAMINER				DATE CONSIDERED 10/30/2006			

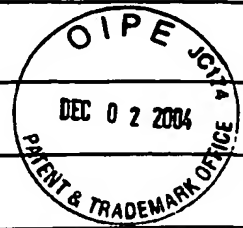
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INFORMATION DISCLOSURE STATEMENT

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Date Submitted to PTO: December 2, 2004

ATTY DOCKET NO.
2004-0092SERIAL NO.
10/761,412APPLICANT
Makoto IMANISHI et al.FILING DATE
January 22, 2004GROUP
1725

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
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	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
AM	AJ	6-232132	8/1994	JP			Partial
AM	AK	64-12555	1/1989	JP			Partial
	AL						
	AM						
	AN						


OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

DATE CONSIDERED

10/30/2006

Sheet 1 of 1		FORM PTO 1449 (modified)		ATTY DOCKET NO. 2004-0092		SERIAL NO. 10/761,412			
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: May 27, 2004				APPLICANT Makoto IMANISHI et al.					
				FILING DATE January 22, 2004 GROUP 1725					
U.S. PATENT DOCUMENTS									
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
AM	AA	6,568,580	05/2003	Narita et al.					
AM	AB	6,494,358	12/2002	Narita et al.					
AM	AC	6,349,447	02/2002	Zimmer					
	AD								
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	AF								
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